

<b>Notice of References Cited</b>		Application/Control No. 10/553,977	Applicant(s)/Patent Under Reexamination YANO ET AL.	
		Examiner BRYAN T. KILPATRICK	Art Unit 1797	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,550,635	08-1996	Saitoh et al.	356/401
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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